MOSFET – Power, P-Channel, Schottky Diode, ChipFET, FETKY, Schottky Barrier Diode

-20 V, -4.4 A, 4.1 A

Features

- Leadless SMD Package Featuring a MOSFET and Schottky Diode
- 40% Smaller than TSOP-6 Package
- Leadless SMD Package Provides Great Thermal Characteristics
- Independent Pinout to each Device to Ease Circuit Design
- Trench P-Channel for Low On Resistance
- Ultra Low V_F Schottky
- Pb-Free Packages are Available

Applications

- Li-Ion Battery Charging
- High Side DC-DC Conversion Circuits
- High Side Drive for Small Brushless DC Motors
- Power Management in Portable, Battery Powered Products

MOSFET MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	eter		Symbol	Value	Units
Drain-to-Source Voltag	е		V _{DSS}	-20	V
Gate-to-Source Voltage	V_{GS}	±8.0	V		
Continuous Drain	Continuous Drain Current (Note 1) Steady State $T_J = 25^{\circ}C$ $T_{J} = 85^{\circ}C$			-3.2	Α
Current (Note 1)		-2.3			
$t \le 5 \text{ s}$ $T_J = 25^{\circ}\text{C}$				-4.4	
Power Dissipation (Note 1)	Steady State T _{.1} = 25°C		P _D	1.1	W
	t ≤ 5 s			2.1	
Pulsed Drain Current	t _p =	: 10 μs	I _{DM}	-13	Α
Operating Junction and	T _J , T _{STG}	–55 to 150	°C		
Source Current (Body D	I _S	2.5	Α		
Lead Temperature for S (1/8" from case for 1		urposes	TL	260	°C

SCHOTTKY DIODE MAXIMUM RATINGS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

Parameter	Symbol	Value	Units
Peak Repetitive Reverse Voltage	V_{RRM}	20	V
DC Blocking Voltage	V_{R}	20	V

1



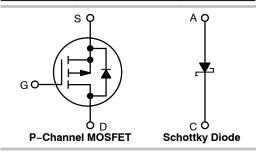
ON Semiconductor®

http://onsemi.com

MOSFET					
V _{(BR)DSS} R _{DS(on)} TYP I _D MAX					
-20 V	64 mΩ @ -4.5 V	4.4.4			
	85 mΩ @ –2.5 V	-4.4 A			

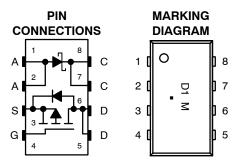
SCHOTTKY DIODE

V _R MAX	V _F TYP	I _F MAX
20 V	0.510 V	4.1 A





ChipFET CASE 1206A STYLE 3



D1 = Specific Device Code M = Month Code ■ = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

SCHOTTKY DIODE MAXIMUM RATINGS

(T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Units
Average Rectified Steady Forward Current State		T _J = 25°C	I _F	2.2	>
	t ≤ 5 s			4.1	Α

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq

[1 oz] including traces).

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	113	°C/W
Junction-to-Ambient - t ≤ 10 s (Note 2)	$R_{ hetaJA}$	60	°C/W

2. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	s	Min	Тур	Max	Units
OFF CHARACTERISTICS	•				-	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -25$	50 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				-15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -16 V, V _{GS} = 0 V	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$			-1.0 -5.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±	<u> </u>			±100	nA
ON CHARACTERISTICS (Note 3)					1	ı	<u> </u>
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = -250 μA		-0.45		-1.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.7		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5$, $I_D = -3.2$ A $V_{GS} = -2.5$, $I_D = -2.2$ A			64	80	mΩ
					85	110	1
		$V_{GS} = -1.8, I_D = -1$	1.0 A		120	170	1
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V}, I_D = -2.9 \text{ A}$			8.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				680		pF
Output Capacitance	Coss	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ N}$ $V_{DS} = -10 \text{ V}$	ЛHz,		100		1
Reverse Transfer Capacitance	C _{RSS}	VD3 = 10 V			70		
Total Gate Charge	Q _{G(TOT)}				7.4		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = I_{D} = -3.2 \text{ A}$	–10 V,		0.6		
Gate-to-Source Charge	Q_{GS}	$I_D = -3.2 \text{ A}$			1.4		
Gate-to-Drain Charge	Q_{GD}				2.5		
SWITCHING CHARACTERISTICS (No	te 4)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -3.2 \text{ A}, R_{G} = 2.4 \Omega$			5.8		ns
Rise Time	t _r				11.7		
Turn-Off Delay Time	t _{d(OFF)}				16		
Fall Time	t _f				12.4		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						-
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = -2.5 \text{ A}$	T _J = 25°C		-0.8	-1.2	V

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Time	t _{RR}			13.5		ns
Charge Time	ta	V _{GS} = 0 V, I _S = -1.0 A ,		9.5		
Discharge Time	t _b	$V_{GS} = 0 \text{ V, } I_{S} = -1.0 \text{ A},$ $dI_{S}/dt = 100 \text{ A}/\mu\text{s}$		4.0		
Reverse Recovery Charge	Q_{RR}			6.5		nC

SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T $_J$ = 25°C unless otherwise noted)

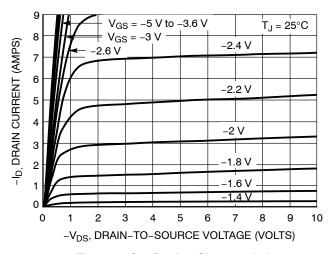
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Maximum Instantaneous	V _F	I _F = 0.1 A		0.425		V
Forward Voltage		I _F = 1.0 A		0.510	0.575	
Maximum Instantaneous	I _R	V _R = 10 V			1.0	μΑ
Reverse Current		V _R = 20 V			5.0	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

 $V_{DS} \ge -10 \text{ V}$



T_C = -55°C

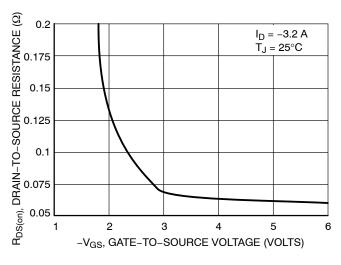
T_C = -55°C

100°C

0 0.5 1 1.5 2 2.5 3 3.5

Figure 1. On-Region Characteristics

 $-V_{GS}$, GATE-TO-SOURCE VOLTAGE (VOLTS) Figure 2. Transfer Characteristics



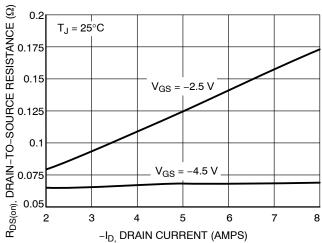
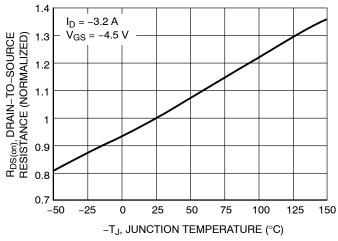


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



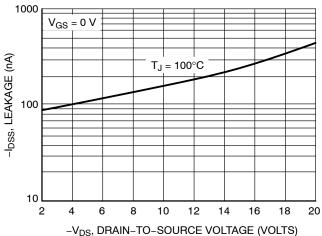
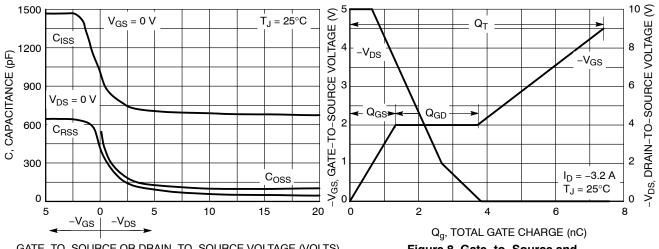


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

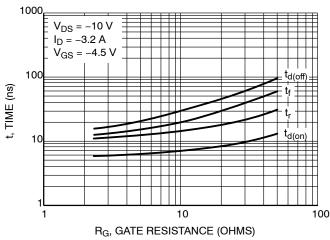


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

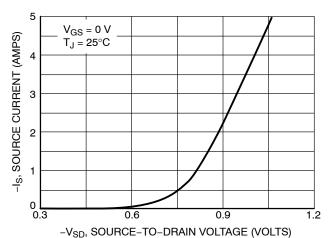
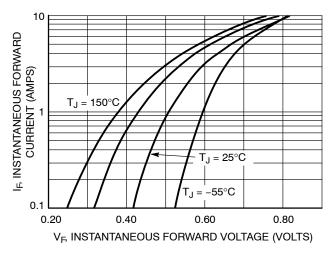


Figure 10. Diode Forward Voltage vs. Current

TYPICAL SCHOTTKY PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



OLTAGE (VOLTS)

Figure 11. Typical Forward Voltage

Figure 12. Maximum Forward Voltage

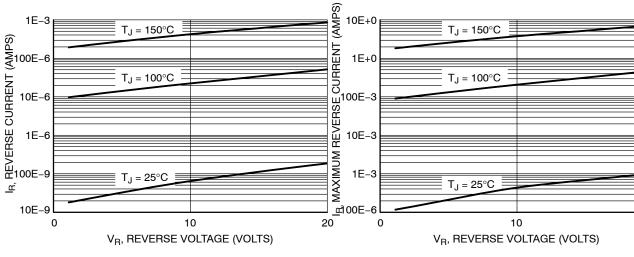
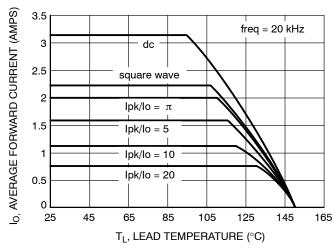


Figure 13. Typical Reverse Current

Figure 14. Maximum Reverse Current

20





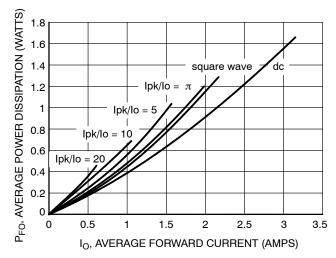


Figure 16. Forward Power Dissipation

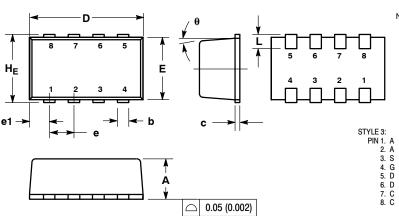
DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTHD3101FT1	ChipFET	3000 / Tape & Reel
NTHD3101FT1G	ChipFET (Pb-Free)	3000 / Tape & Reel
NTHD3101FT3	ChipFET	10000 / Tape & Reel
NTHD3101FT3G	ChipFET (Pb-Free)	10000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 **ISSUE J**



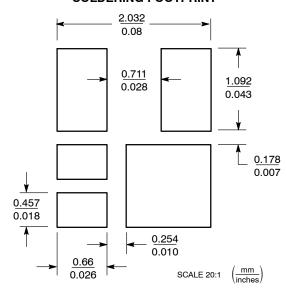
NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD

SURFACE.

	MILLIMETERS			LLIMETERS INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.00	1.05	1.10	0.039	0.041	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
С	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
E	1.55	1.65	1.70	0.061	0.065	0.067
е		0.65 BSC			0.025 BSC)
e1		0.55 BSC			0.022 BSC	
L	0.28	0.35	0.42	0.011	0.014	0.017
HE	1.80	1.90	2.00	0.071	0.075	0.079
θ	5° NOM				5° NOM	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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